

Notice of References Cited

Application/Control No.

10/581,817

Applicant(s)/Patent Under
Reexamination
HOFFMEISTER ET AL.

Examiner

DIEU HIEN T. DUONG

Art Unit

2821

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,334,988	08-1994	Murakami et al.	343/704
*	B	US-2004/0056810	03-2004	Oka, Hidetoshi	343/713
	C	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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